

Search Notes

Application/Control No.

10/047,758

Examiner

Raj K. Jain

Applicant(s)/Patent under
Reexamination

CHANG, TU-YIIN

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Interference search, see printout		11/21/2006	RJ

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Chi Pham for claims 1, 6 and 10. Claims contain 112 1st issue.	3/14/2006	RJ
Consulted with Wellington Chin, concurred claims 6 and 10 contain 112 1st issue.	3/15/2006	RJ
Searched US PG PUB, US PAT, TEXT SEARCH; SEE ATTACHED	3/14/2006	RJ
370/503,507,509,518,520 text search see printout.	3/14/2006	RJ
375/354,356,355,371,372,373,374,37 5,376 text search, see printout	3/14/2006	RJ